

Search Notes

Application/Control No.

09/470,234

Examiner

Hae M. Hyeon

Applicant(s)/Patent under
Reexamination

SALGADO ET AL.

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
439	489	9/09	hnh
439	676	↓	↓
439	540.1	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR